# Operational experience with the movable emittance-meter at SPARC

#### L.Catani on behalf of the SPARC Collaboration



# outline

 work done with e-meter during photo-injector commissioning

 x results from SPARC photo-injector commissioning (refer to THPPH031)
x complete list of measurements one can do with this device









### **SPARC Working Point**



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### Motivations for the movable emittance meter

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Emittance Compensation: Controlled Damping of Plasma Oscillations (Homdyn simulations by M.Ferrario and SPARC-BD group)

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### movable emittance-meter concept



### a closer look



### the emittance measurement



$$\varepsilon_n^2 = \frac{1}{N^2} \left\{ \sum_{j=1}^p \left[ n_j \left( x_{sj} - \overline{x} \right)^2 \right] \cdot \sum_{j=1}^p \left[ n_j \sigma_{x'_j}^2 + n_j \left( \overline{x'_j} - \overline{x'} \right)^2 \right] + \left[ \sum_{j=1}^p n_j x_{sj} \overline{x'_j} - N \overline{x} \overline{x'} \right]^2 \right\}$$

where

p = total number of slits

 $n_i$  = particles in the beamlet from the j-th slit

- $x_{si}$  = position on the j-th slit on the slit-mask
- $\overline{x}$  = mean position of all the beamlets
- $\overline{x}'_j$  = mean divergence of the j-th beamlet
- $\overline{x'}$  = mean divergence of all beamlets

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 $\sigma_{x'_i}$  = RMS divergence of the j-th beamlet





### Multi-slits or multi-shot measurements



In the waist area, or at positions where the beam is too small to use multi-slits mask, we plan to use a single slit be moved transversally with respect to the beam. For this multi-shot measurement the step size, and as consequence the number of the samples of the beam, can be varied to improve the accuracy.



Multi-slits mask with a fixed distance (0.5 mm) between slits will be used where the beam is large (right) but this cannot be a good choice if its size is small as in the beam waist region (left).

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### Test and preliminary

#### **commissioning @PITZ** (INFN&DESY-Zeuthen teams)



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### TEST @ PITZ (INFN&DESY-Zeuthen Teams)



- A good chance to debug and test the system on the field.
- Cross-check results with PITZ EMSY measurements.
- Energy too high (with booster on) to have some changes of emittance vs. z





### Measurements @ PITZ (INFN&DESY-Zeuthen teams)



# installation @ SPARC



## beam envelope vs. Z (A.Cianchi)

it's the "level 0" measurement with e-meter Provides information about:

- onsoletickichteasusiegnent
- complete stad takes ≈5 min.
- beaplesized ≈ 120 ms 1000 µm RMS
  - laser incidence angle



## envelope.vs.z movie







### Results from emittance measurements



#### check beam alignment and size



### ε along z





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#### experience from emittance measurements

• We used both single-slit and multi-slits masks. Multi-slits is a single shot measurement (faster), single-slit gives more sampling points (more accurate - usually 9 beamlets are OK)





- Multi-slit is not preferable when beam is either converging or too small (because of fixed distance between slits produces low transverse sampling)
- Good agreement between single slit and multi slits measurements.





#### experience from emittance measurements



 We cross-check the results of emittance calculation comparing the measured RMS beam size (with a screen at slit-mask position) and the value obtained from Twiss parameters produced by the analysis routine.







### x' change along z evidences

the space-charge dominated regime

### beam energy vs.transverse position



# beam energy spread vs. Z







# beam energy spread vs. Z

The central part of the beam is selected with the 50 um slit (beam charge is reduced down to  $\approx$ 5%) and the energy spread is measured after the dipole moving the mask at different z.

Downstream the slit mask the beam propagates without SC and longitudinal WF and energy spread "freezes" after the cut.



#### check simulations against measurement (SPARC-BD group)

**INPUT BEAM** .20000 564 Q = 700 pC423 .10000 Energy = 5.14 MeV 282 0 σ<sub>7</sub>=4.35 psec (gaussian longitudinal distribution) 141 -.10000  $\sigma_x = \sigma_v \approx 0.5 \text{ mm}$ phase spectrum y vs. x (round beam) -.20000 .10000 .20000 BEAM EMITTANCES BEAM ENVELOPES 2.5 Exn measured Eyn measured Xrms(mm)-computed Exn (mm-mrad)-computed Yrms(mm)-computed 2 Eyn(mm-mrad)-computed x(mm)-measured  $\sigma_y$  fits pretty well with meas. y(mm)-measured 1.5 the same is for ε<sub>v</sub> 1 X-plane ? 0.5 2 0 0 50 100 150 200 40 60 80 100 120 140 160 180 200 z(cm) Z(cm) L. Catani - INFN Roma Tor Vergata 24 FEL2006 - Berlin

#### compare measurements-computations

INPUT BEAM Q = 700 pCEnergy = 5.14 MeV  $\sigma_z$ =4.35 psec (gaussian longitudinal distribution)

 $\sigma_x / \sigma_y = 1.2$ (elliptical beam)

now  $\sigma_x$  fits better (though we lost something on the y-plane)

Moreover  $\varepsilon_x$  and  $\varepsilon_y$  should have minima with different z: we can check both if we increase focusing to move minima inside the e-meter zrange.

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#### compare measurements-computations



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# Conclusion

- more systematic measurements of SPARC the photo-injector are scheduled for the next weeks. Comparisons made with simulations look promising.
- probably we are still at the beginning in exploring the possible applications of the movable emittance-meter
- more than a simple improvement over more conventional emittance diagnostic this device defines a new strategy for characterizing high performance photo-injectors as it allows a detailed analysis of the beam dynamic over a section of the accelerator where crucial beam shaping takes place

